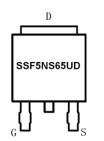
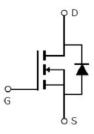


Main Product Characteristics:

V _{DSS}	650V		
R _{DS} (on)	0.74Ω (typ.)		
I _D	5A ①		

Silicion





TO-252 (DPAK)

Marking and pin Assignment

Schematic diagram

Features and Benefits:

- High dv/dt and avalanche capabilities
- 100% avalanche tested
- Low input capacitance and gate charge
- Low gate input resistance



Description:

The SSF5NS65UD series MOSFETs is a new technology, which combines an innovative super junction technology and advance process. This new technology achieves low Rdson, energy saving, high reliability and uniformity, superior power density and space saving.

Absolute max Rating:

Symbol	Parameter	Max.	Units
I _D @ TC = 25°C	Continuous Drain Current, V _{GS} @ 10V	5 ①	
I _D @ TC = 100°C	Continuous Drain Current, V _{GS} @ 10V	3.2 ①	А
I _{DM}	Pulsed Drain Current 2	15	
	Power Dissipation 3	50	W
P _D @TC = 25°C	Linear Derating Factor	0.4	W/°C
V _{DS}	Drain-Source Voltage	650	V
V _{GS}	Gate-to-Source Voltage	± 30	V
E _{AS}	Single Pulse Avalanche Energy @ L=22.4mH	54	mJ
I _{AR}	Avalanche Current @ L=22.4mH	2.2	А
T _J T _{STG}	Operating Junction and Storage Temperature Range	-55 to +150	°C



Thermal Resistance

Symbol	Characterizes	Тур.	Max.	Units
R _{θJC}	Junction-to-case 3	—	2.5	°CW
R _{0JA}	Junction-to-ambient (t \leq 10s) (4)	—	75	°C /W

Electrical Characterizes $@T_A=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions	
V _{(BR)DSS}	Drain-to-Source breakdown voltage	650	_	_	V	$V_{GS} = 0V, I_D = 250 \mu A$	
D	Static Drain-to-Source on-resistance	_	0.74	1.0	Ω	V_{GS} =10V,I _D = 1A	
R _{DS(on)}	Static Drain-to-Source on-resistance	_	1.54	—		T _J = 125°C	
Maann	Gate threshold voltage	2	—	4	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$	
V _{GS(th)}	Gale intestiold voltage	—	2.2	—	v	T _J = 125°C	
	Drain to Source lookage ourrent	_	—	1		$V_{DS} = 650 V, V_{GS} = 0 V$	
I _{DSS}	Drain-to-Source leakage current	_	—	50	μA	$T_J = 125^{\circ}C$	
	Cata to Source forward lookage	—	—	100	nA	V _{GS} =30V	
I _{GSS} Gate-to-	Gate-to-Source forward leakage	_	—	-100		V _{GS} = -30V	
Qg	Total gate charge	—	8.1	—		$I_D = 4A$,	
Q_{gs}	Gate-to-Source charge	_	2.4	—	nC	V _{DS} =100V,	
Q_{gd}	Gate-to-Drain("Miller") charge	—	2.8	—		$V_{GS} = 10V$	
t _{d(on)}	Turn-on delay time	_	9.0	—			
tr	Rise time	_	5.9	—	ns	V_{GS} =10V, V_{DS} =200V,	
$t_{d(off)}$	Turn-Off delay time	—	23	—	115	R_{GEN} =12.2 Ω , I_{D} =1.9A	
t _f	Fall time	_	11	—			
Ciss	Input capacitance	_	336	_		$V_{GS} = 0V$	
Coss	Output capacitance	_	18	_	pF	V _{DS} = 100V	
C _{rss}	Reverse transfer capacitance		2.8	_		f = 1MHz	

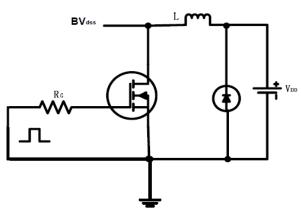
Source-Drain Ratings and Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
	Continuous Source Current			5 ①	А	MOSFET symbol
I _S	(Body Diode)	_				showing the
la	Pulsed Source Current			15	۸	integral reverse
I _{SM}	(Body Diode)		_	15	A	p-n junction diode.
V _{SD}	Diode Forward Voltage		0.83	1.2	V	I _S =2.8A, V _{GS} =0V
t _{rr}	Reverse Recovery Time	_	105	_	nS	$T_J = 25^{\circ}C, I_F = 1.9A,$
Qrr	Reverse Recovery Charge		514		nC	di/dt = 100A/µs

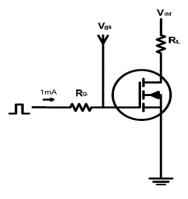


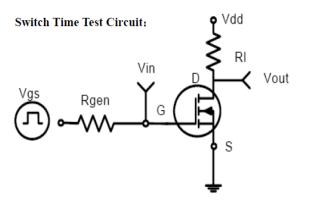
Test circuits and Waveforms

EAS test circuits:

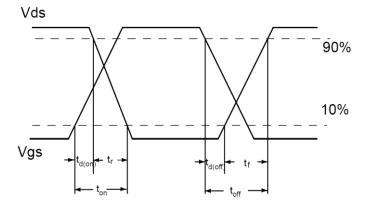


Gate charge test circuit:





Switch Waveforms:



Notes:

- ①Calculated continuous current based on maximum allowable junction temperature.
- 2 Repetitive rating; pulse width limited by max. junction temperature.
- ③The power dissipation PD is based on max. junction temperature, using junction-to-case thermal resistance.
- (4) The value of $R_{\theta JA}$ is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with TA =25°C



Typical electrical and thermal characteristics

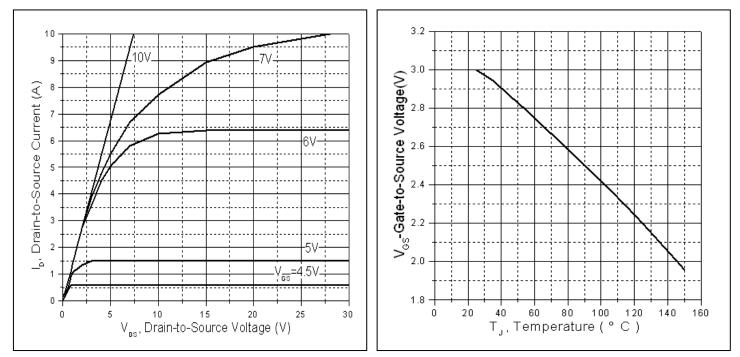
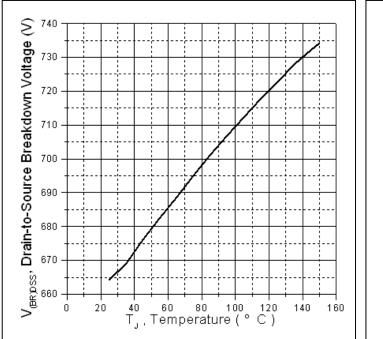


Figure 1: Typical Output Characteristics



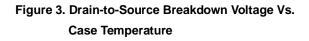
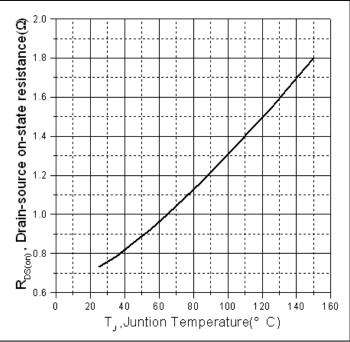
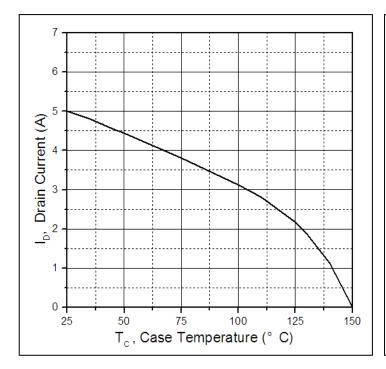


Figure 2. Gate to source cut-off voltage



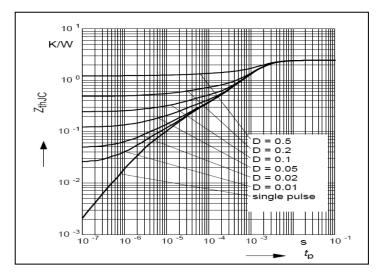


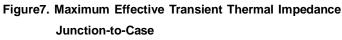




Typical electrical and thermal characteristics







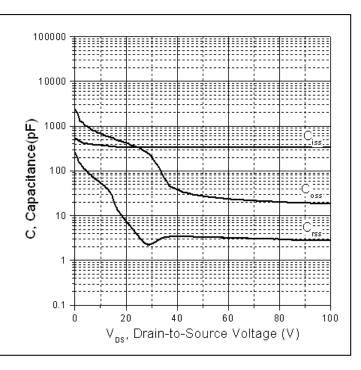
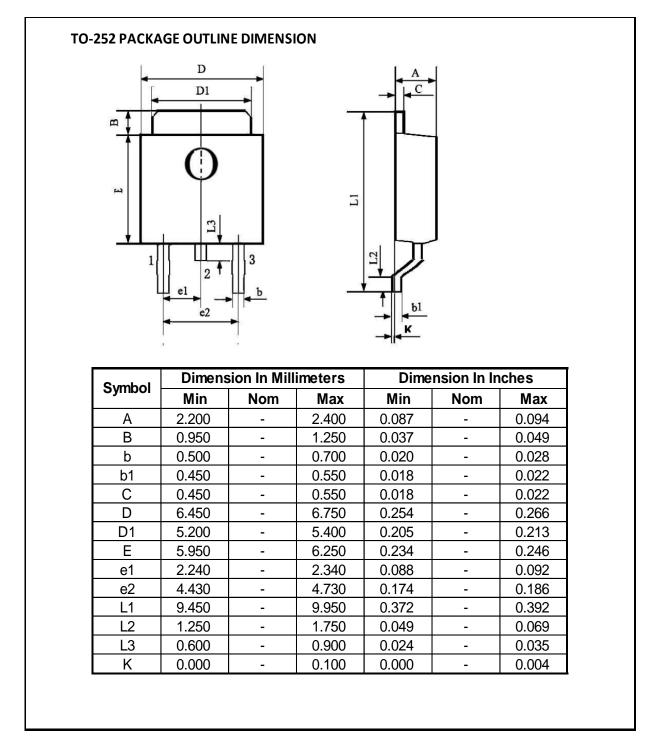


Figure 6. Typical Capacitance Vs. Drain-to-Source Voltage



Mechanical Data:





Ordering and Marking Information

Device Marking: SSF5NS65UD

Package (Available) TO-252(DPAK) Operating Temperature Range C : -55 to 150 °C

Devices per Unit (options)

Package Type	Units/Tape	Tapes/Inner Box	Units/Inner Box	Inner Boxes/Carton	Units/Carton Box
				Box	
TO-252	2500	2	5000	7	35000
TO-252	2500	1	2500	10	25000
TO-252	800	5	4000	8	32000

Reliability Test Program

Test Item	Conditions	Duration	Sample Size
High	T _j =125℃ to 150℃ @	168 hours	3 lots x 77 devices
Temperature	80% of Max	500 hours	
Reverse	V _{DSS} /V _{CES} /VR	1000 hours	
Bias(HTRB)			
High	T _j =150℃ @ 100% of	168 hours	3 lots x 77 devices
Temperature	Max V _{GSS}	500 hours	
Gate		1000 hours	
Bias(HTGB)			



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Customer Service

Worldwide Sales and Service:

Sales@silikron.com

Technical Support:

Technical@silikron.com

Suzhou Silikron Semiconductor Corp.

11A, 428 Xinglong Street, Suzhou Industrial Park, P.R.China

TEL: (86-512) 62560688

FAX: (86-512) 65160705

E-mail: Sales@silikron.com